

<b>Notice of References Cited</b>	Application/Control No. 10/789,679	Applicant(s)/Patent Under Reexamination JANG, HYEON-YONG	
	Examiner Minh D. A	Art Unit 2821	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,362,575	03-2002	Chang et al.	315/224
	B	US-6,396,722	05-2002	Lin, Yung-Lin	363/98
	C	US-5,973,455	10-1999	Mirskiy et al.	315/105
	D	US-6,259,615	07-2001	Lin, Yung-Lin	363/98
	E	US-2003/0098861	05-2003	Nakatsuka et al.	345/212
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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